Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/813,270	PAN, MENG-AN
Examiner	Art Unit

Nhan T. Le

2618

SEARCHED						
Class	Subclass	Date	Examiner			
495	205, 208 209	06/20/06	N.Ce			
	2/3					
	319,325 324,358 334341					
	324,358					
	33934					
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
East search	06/26/06	N.le			
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